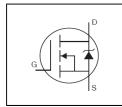


AUTOMOTIVE GRADE

AUIRF1010Z AUIRF1010ZS AUIRF1010ZL

Features

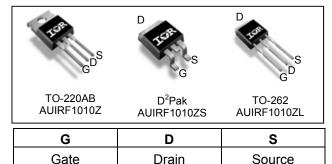
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- · Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



HEXFE	T [®] Power MOSFET
V _{DSS}	55V
R _{DS(on)} max.	7.5mΩ
D (Silicon Limited)	94A
D (Package Limited)	75A

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



Base next number Backene Type		Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRF1010Z	TO-220	Tube	50	AUIRF1010Z
AUIRF1010ZL	TO-262	Tube	50	AUIRF1010ZL
AUIRF1010ZS	D²-Pak	Tube	50	AUIRF1010ZS
AUIRF 101025	D-rak	Tape and Reel Left	800	AUIRF1010ZSTRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	94		
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	66	1	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	75	A	
I _{DM}	Pulsed Drain Current ①	360	1	
P _D @T _C = 25°C	Maximum Power Dissipation	140	W	
	Linear Derating Factor	0.90	W/°C	
V_{GS}	Gate-to-Source Voltage	± 20	V	
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	130	ma I	
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value ®	180	- mJ	
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α	
E _{AR}	Repetitive Avalanche Energy ®		mJ	
TJ	Operating Junction and	-55 to + 175		
T_{STG}	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds (1.6mm from case)	300		
_	Mounting torque, 6-32 or M3 screw⑦	10 lbf•in (1.1N•m)		

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case 9		1.11	
$R_{ heta CS}$	Case-to-Sink, Flat, Greased Surface ⑦	0.50		°CAM
R_{\thetaJA}	Junction-to-Ambient ⑦		62	°C/W
$R_{ hetaJA}$	Junction-to-Ambient (PCB Mount, steady state) ®		40	

HEXFET® is a registered trademark of Infineon.

2017-09-18

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.049		V/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		5.8	7.5	mΩ	V _{GS} = 10V, I _D = 75A ③
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
gfs	Forward Trans conductance	33			S	$V_{DS} = 25V, I_{D} = 75A$
	Drain-to-Source Leakage Current			20	μA	$V_{DS} = 55 \text{ V}, V_{GS} = 0 \text{ V}$
I _{DSS}	Diam-to-Source Leakage Current			250	μΑ	$V_{DS} = 55V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
	Gate-to-Source Forward Leakage			200	n 1	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-200	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

•	O , (•	,		
Q_g	Total Gate Charge	 63	95		I _D = 75A
Q_{gs}	Gate-to-Source Charge	 19		nC	V _{DS} = 44V
Q_{gd}	Gate-to-Drain Charge	 24			V _{GS} = 10V3
$t_{d(on)}$	Turn-On Delay Time	 18			$V_{DD} = 28V$
t _r	Rise Time	 150		no	I _D = 75A
$t_{d(off)}$	Turn-Off Delay Time	 36		ns	$R_G = 6.8\Omega$
t _f	Fall Time	 92			V _{GS} = 10V ③
L_D	Internal Drain Inductance	 4.5		nH	Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 7.5		1111	from package and center of die contact
C_{iss}	Input Capacitance	 2840			$V_{GS} = 0V$
C_{oss}	Output Capacitance	 420			V _{DS} = 25V
C_{rss}	Reverse Transfer Capacitance	 250		pF	f = 1.0MHz, See Fig. 5
C _{oss}	Output Capacitance	 1630		рΓ	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
Coss	Output Capacitance	 360			$V_{GS} = 0V$, $V_{DS} = 44V$ $f = 1.0MHz$
Coss eff.	Effective Output Capacitance	 560			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V $
D: 1 01					

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			75		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			360		integral reverse p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 75A, V_{GS} = 0V $ ③
t _{rr}	Reverse Recovery Time		22	33	ns	$T_J = 25^{\circ}C$, $I_F = 75A$, $V_{DD} = 25V$
Q_{rr}	Reverse Recovery Charge		15	23	nC	di/dt = 100A/µs ③
t _{on}	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L _S +L _D)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 0.05mH, $R_G = 25\Omega$, $I_{AS} = 75$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- \odot This value determined from sample failure population, starting T_J = 25°C, L = 0.05mH, R_G = 25 Ω , I_{AS} = 75A, V_{GS} =10V.
- This is only applied to TO-220AB package.
- ® When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- [®] R_θ is measured at T_J approximately 90°C.



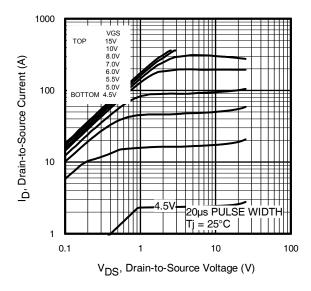


Fig. 1 Typical Output Characteristics

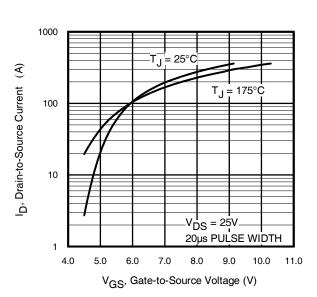


Fig. 3 Typical Transfer Characteristics

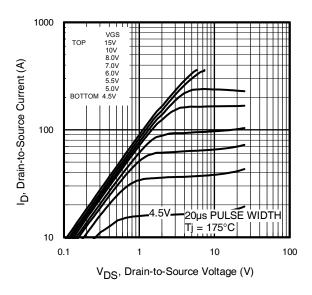


Fig. 2 Typical Output Characteristics

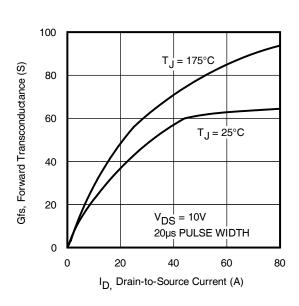


Fig. 4 Typical Forward Trans conductance vs. Drain Current



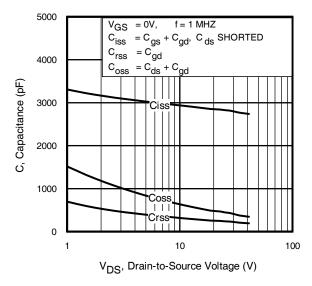


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

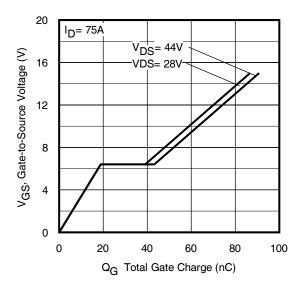


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

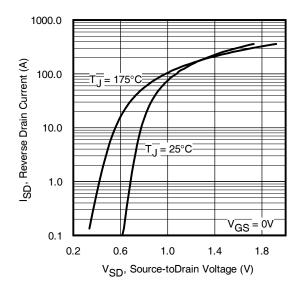


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

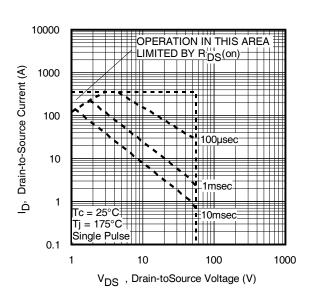
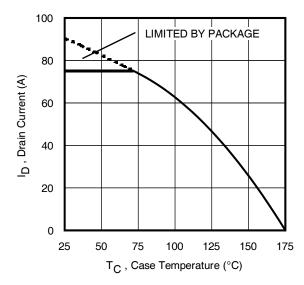


Fig 8. Maximum Safe Operating Area





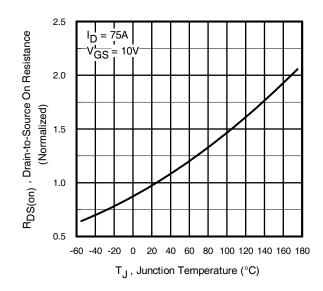


Fig 9. Maximum Drain Current vs. Case Temperature

Fig 10. Normalized On-Resistance vs. Temperature

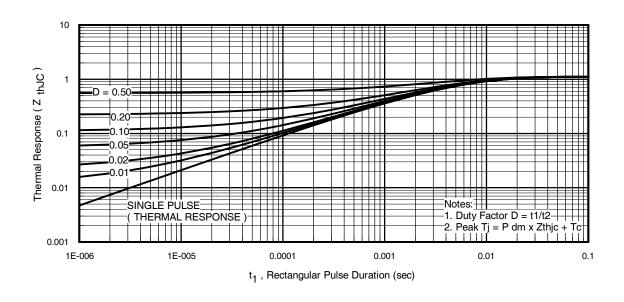


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



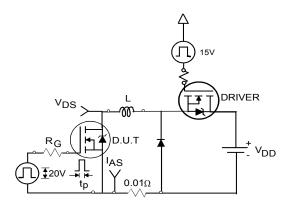


Fig 12a. Unclamped Inductive Test Circuit

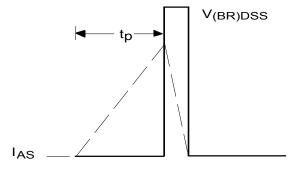


Fig 12b. Unclamped Inductive Waveforms

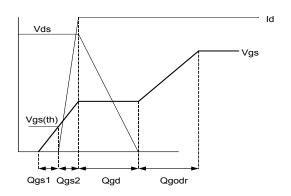


Fig 13a. Gate Charge Waveform

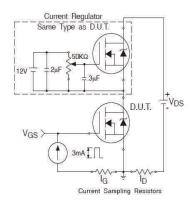


Fig 13b. Gate Charge Test Circuit

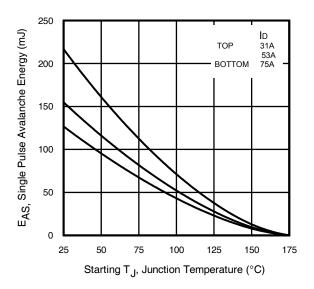


Fig 12c. Maximum Avalanche Energy vs. Drain Current

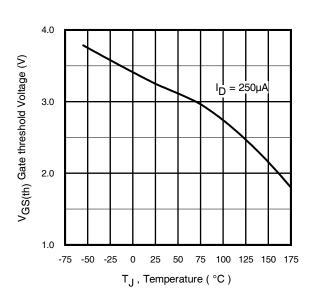


Fig 14. Threshold Voltage vs. Temperature



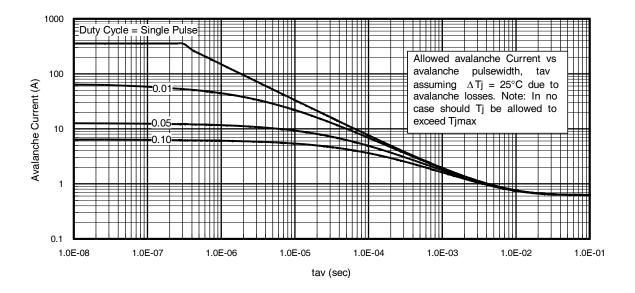


Fig 15. Typical Avalanche Current vs. Pulse width

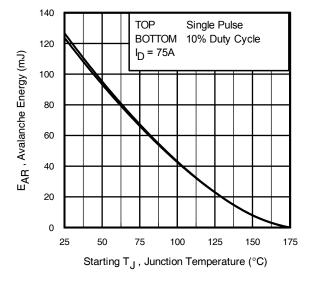


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16: (For further info, see AN-1005 at www.infineon.com)

- 1. Avalanche failures assumption:
 - Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



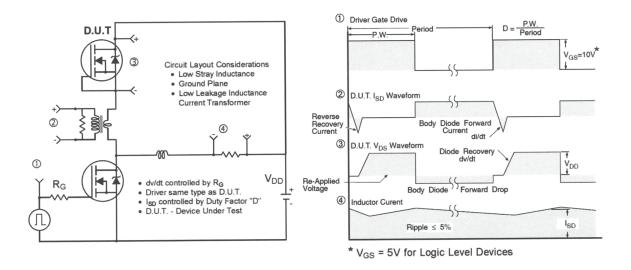


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

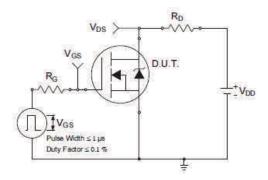


Fig 18a. Switching Time Test Circuit

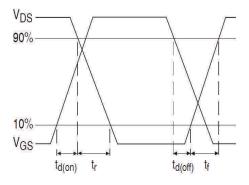
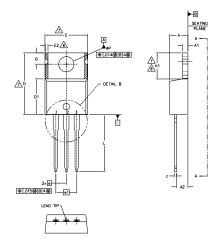
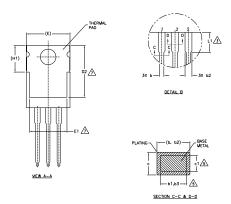


Fig 18b. Switching Time Waveforms



TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





NOTES:

- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.

- DIMENSIONING AND TOLERANGING AS PER ASMETTIS, 3M 1994.

 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].

 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

 DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH

 SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.

- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.
- OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	3.56	4.83	.140	.190	
A1	1.14	1.40	.045	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.97	.015	.038	5
b2	1,14	1.78	.045	.070	
b3	1,14	1.73	.045	.068	5
С	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	-	.030	8
e	2.54 5.08	BSC	.100 .200	BSC	
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3.56	4.06	.140	.160	3
ØΡ	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

LEAD ASSIGNMENTS

HEXFET

1.- GATE 2.- DRAIN 3.- SOURCE

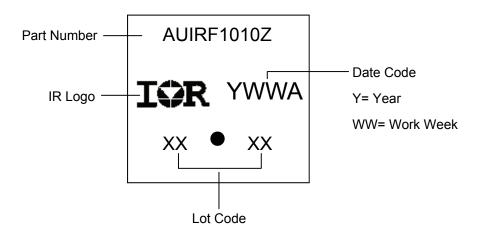
IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

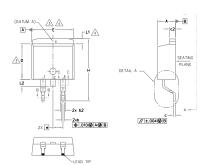
TO-220AB Part Marking Information

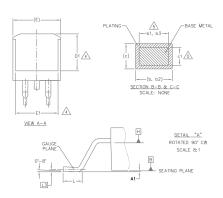


TO-220AB package is not recommended for Surface Mount Application.



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S Y M	DIMENSIONS				
B	MILLIM	MILLIMETERS INCHES			
L	MIN.	MAX.	MIN.	MAX.	O T E S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	_	1.78	_	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE

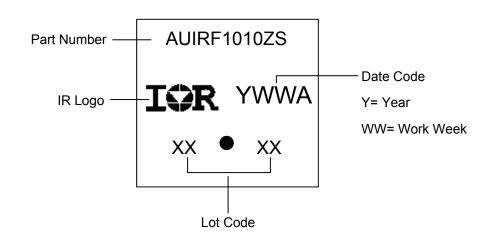
HEXFET

IGBTs, CoPACK

1.- GATE 2, 4.- DRAIN 3.- SOURCE

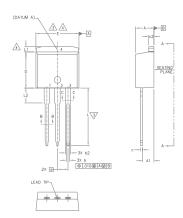
2, 4.- COLLECTOR 3.- EMITTER

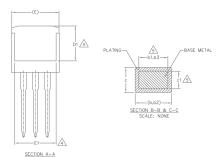
D²Pak (TO-263AB) Part Marking Information





TO-262 Package Outline (Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3\DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

DIODES

- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

LEAD ASSIGNMENTS

IGBTs, CoPACK

- 1.- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

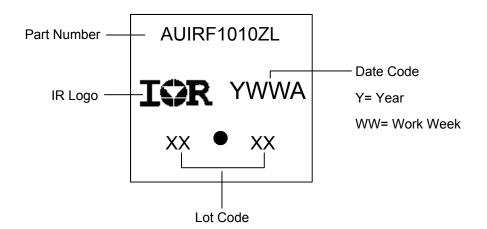
HEXFET

1.- GATE

1.- ANODE (TWO DIE) / OPEN (ONE DIE)
2, 4.- CATHODE
3.- ANODE 2.- DRAIN 3.- SOURCE 4.- DRAIN

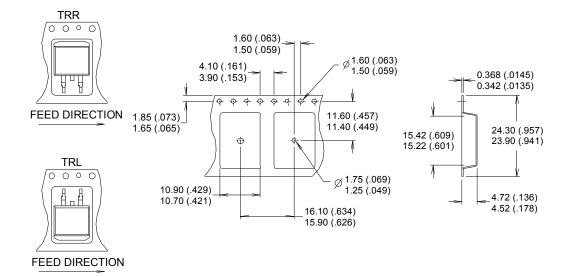
S Y M	DIMENSIONS					
В	MILLIM	MILLIMETERS INCHES				
0 L	MIN.	MAX.	MIN.	MAX.	O T E S	
Α	4.06	4.83	.160	.190		
A1	2.03	3.02	.080	.119		
b	0.51	0.99	.020	.039		
ь1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
b3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	-	.270	_	4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	_	.245		4	
е	2.54	BSC	.100	BSC		
L	13.46	14.10	.530	.555		
L1	_	1.65	_	.065	4	
L2	3.56	3.71	.140	.146		

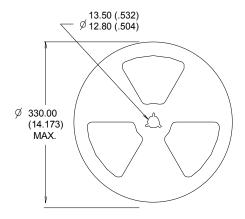
TO-262 Part Marking Information





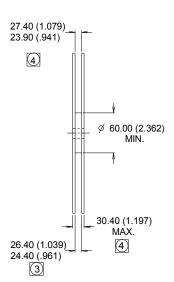
D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))







- COMFORMS TO EIA-418.
- CONTROLLING DIMENSION: MILLIMETER.
- 3
- DIMENSION MEASURED @ HUB.
 INCLUDES FLANGE DISTORTION @ OUTER EDGE.





Qualification Information

		Automotive			
		(per AEC-Q101)			
Qualificati	on Level		is part number(s) passed Automotive qualification. Infineon's consumer qualification level is granted by extension of the higherel.		
Moisture Sensitivity Level		TO-220AB	N/A		
		TO-262	MOL 4		
			MSL1		
	Machine Madel	Class M4 (+/- 700V) [†]			
	Machine Model		AEC-Q101-002		
FOD	Lluman Dady Madal	Class H1C (+/-1500V) [†]			
ESD	Human Body Model	AEC-Q101-001			
	Channed Davise Medal		Class C5 (+/-2000V) [†]		
Charged Device Model		AEC-Q101-005			
RoHS Con	npliant	Yes			

[†] Highest passing voltage.

Revision History

Date	Comments				
11/6//2015	 Updated datasheet with corporate template Corrected ordering table on page 1. 				
9/18/2017	Corrected typo error on part marking on page 9,10,11.				

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